Search Notes



	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10556727	OHASHI ET AL.
Ì	Examiner	Art Unit
	Tran, Len	1725

	SEAR	CHED		
Class	Subclass		Date	Examiner
164	459, 476		3/27/07	LT

SEARCH NOT	ES	
Search Notes	Date	Examiner
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	INTERFERENCE SEA	ARCH	
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